74ABT827 10-bit buffer/line driver; non-inverting; 3-state Rev. 5 – 7 November 2011

Product data sheet

1. General description

The 74ABT827 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT827 10-bit buffers provide high performance bus interface buffering for wide data/address paths or buses carrying parity. They have NOR Output Enables ($\overline{OE0}$, $\overline{OE1}$) for maximum control flexibility.

2. Features and benefits

- Ideal where high speed, light loading, or increased fan-in are required
- Flow-through pinout architecture for microprocessor oriented applications
- Output capability: +64 mA and -32 mA
- Power-up 3-state
- Inputs are disabled during 3-state mode
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V

3. Ordering information

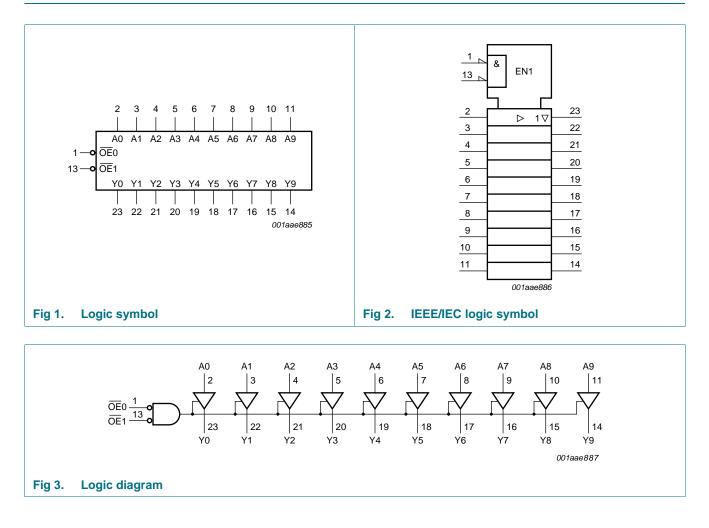
Table 1.Ordering information

Type number	Package	Package						
	Temperature range	Name	Description	Version				
74ABT827D	–40 °C to +85 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1				
74ABT827DB	–40 °C to +85 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1				
74ABT827PW	–40 °C to +85 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1				



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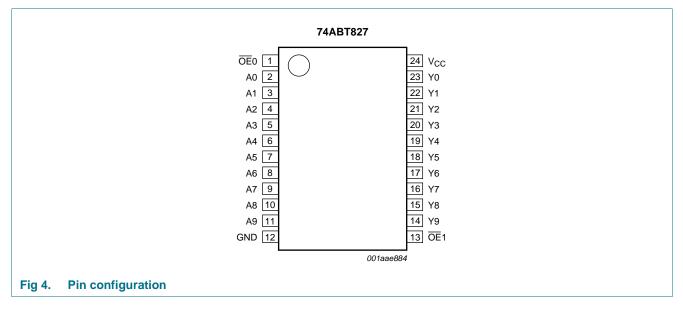
4. Functional diagram



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5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.	Pin description	
Symbol	Pin	Description
OE0	1	output enable input (active LOW)
A0 to A9	2, 3, 4, 5, 6, 7, 8, 9, 10, 11	data input
GND	12	ground (0 V)
OE1	13	output enable input (active LOW)
Y0 to Y9	23, 22, 21, 20, 19, 18, 17, 16, 15, 14	data output
V _{CC}	24	supply voltage

6. Functional description

6.1 Function table

Table 3.	Function table ^[1]			
Inputs			Output	Operating mode
OEn	An		Yn	-
L	L		L	transparent
L	Н		Н	transparent
Н	Х		Z	high-impedance

[1] H = HIGH voltage level;

L = LOW voltage level;

X = don t care;

Z = high-impedance OFF-state.

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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V ₁ < 0 V	-18	-	mA
I _{OK}	output clamping current	V _O < 0 V	-50	-	mA
lo	output current	output in LOW-state	-	128	mA
Tj	junction temperature		[2] _	150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	V _{CC}	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-32	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA
$\Delta t / \Delta V$	input transition rise and fall rate		0	-	5	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

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9. Static characteristics

Symbol	Parameter	Conditions			25 °C		_40 °C +	o +85 °C	Unit
Symbol	raianietei			Min	Тур	Max	Min	Max	Unit
V _{IK}	input clamping voltage	V _{CC} = 4.5 V; I _{IK} = -18 mA		-1.2	-0.9	-	-1.2	-	V
V _{OH}	HIGH-level output	$V_{I} = V_{IL} \text{ or } V_{IH}$			0.0				•
OII	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	V
V _{OL}	LOW-level output voltage	$V_{CC} = 4.5 \text{ V}; I_{OL} = 64 \text{ mA};$ $V_I = V_{IL} \text{ or } V_{IH}$		-	0.42	0.55	-	0.55	V
I _I	input leakage current	V_{CC} = 5.5 V; V _I = GND or 5.5 V		-	±0.01	±1.0	-	±1.0	μA
I _{OFF}	power-off leakage current	V_{CC} = 0 V; V_{I} or $V_{O} \leq 4.5$ V		-	±5.0	±100	-	±100	μA
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} = 2.0 \text{ V}; V_O = 0.5 \text{ V};$ V _I = GND or V _{CC} ; OEn HIGH	<u>[1]</u>	-	±5.0	±50	-	±50	μΑ
l _{oz}	OFF-state output current	V_{CC} = 5.5 V; V_I = V_{IL} or V_{IH}							
		V _O = 2.7 V		-	5.0	50	-	50	μΑ
		V _O = 0.5 V		-	-5.0	-50	-	-50	μΑ
I _{LO}	output leakage current	HIGH-state; $V_O = 5.5 V$; $V_{CC} = 5.5 V$; $V_I = GND \text{ or } V_{CC}$		-	5.0	50	-	50	μΑ
lo	output current	V_{CC} = 5.5 V; V_{O} = 2.5 V	[2]	-180	-80	-50	-180	-50	mA
I _{CC}	supply current	V_{CC} = 5.5 V; V_{I} = GND or V_{CC}							
		outputs HIGH-state		-	0.5	250	-	250	μA
		outputs LOW-state		-	25	38	-	38	mA
		outputs disabled		-	0.5	250	-	250	μΑ
ΔI _{CC}	additional supply current	per input pin; $V_{CC} = 5.5$ V; one input at 3.4 V; other inputs at V_{CC} or GND	<u>[3]</u>						
		outputs enabled		-	0.5	1.5	-	1.5	mA
		outputs 3-state, one data input		-	0.01	50	-	50	mA
		outputs 3-state; one enable input		-	0.5	1.5	-	1.5	mA
CI	input capacitance	$V_I = 0 V \text{ or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_0 = 0 V$ or V_{CC}		-	7	-	-	-	pF

[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V with a transition time of up to 10 ms. For V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 %, a transition time of up to 100 μ s is permitted.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[3] This is the increase in supply current for each input at 3.4 V.

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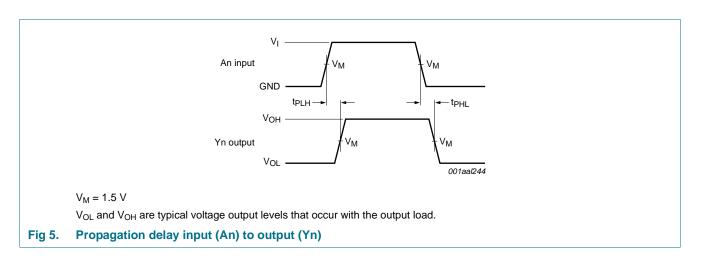
10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; for test circuit, see <u>Figure 7</u>.

Symbol	Parameter	Conditions	25 °C; V _{CC} = 5.0 V			-40 °C to +85 °C; V _{CC} = 5.0 V ± 0.5 V		Unit
			Min	Тур	Max	Min	Max	
t _{PLH}	LOW to HIGH propagation delay	An to Yn; see Figure 5	1.1	3.0	4.4	1.1	4.8	ns
t _{PHL}	HIGH to LOW propagation delay	An to Yn; see Figure 5	1.1	2.9	4.1	1.1	4.7	ns
t _{PZH}	OFF-state to HIGH propagation delay	OEn to Yn; see Figure 6	1.6	3.7	5.1	1.6	5.9	ns
t _{PZL}	OFF-state to LOW propagation delay	OEn to Yn; see Figure 6	2.6	4.6	5.9	2.6	6.9	ns
t _{PHZ}	HIGH to OFF-state propagation delay	OEn to Yn; see Figure 6	2.0	4.8	6.3	2.0	6.8	ns
t _{PLZ}	LOW to OFF-state propagation delay	OEn to Yn; see Figure 6	2.5	5.1	6.6	2.5	6.9	ns

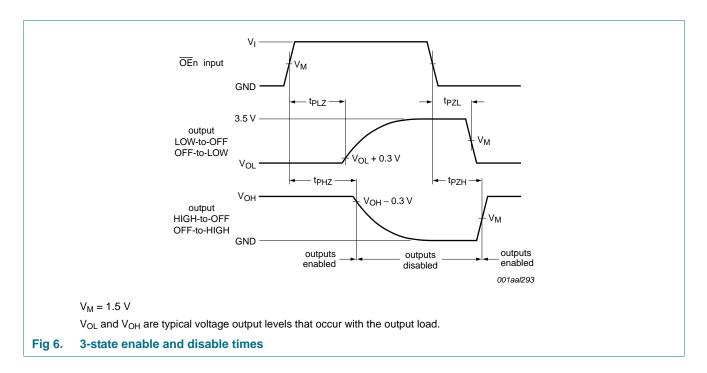
11. Waveforms

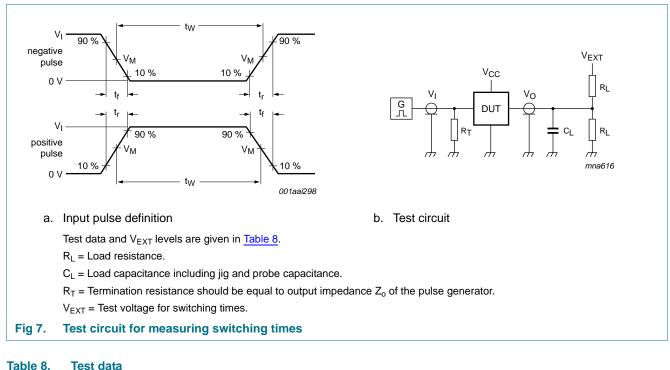


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Input			Load		V _{EXT}			
VI	fı	tw	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}
3.0 V	1 MHz	500 ns	\leq 2.5 ns	50 pF	500 Ω	open	open	7.0 V

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12. Package outline

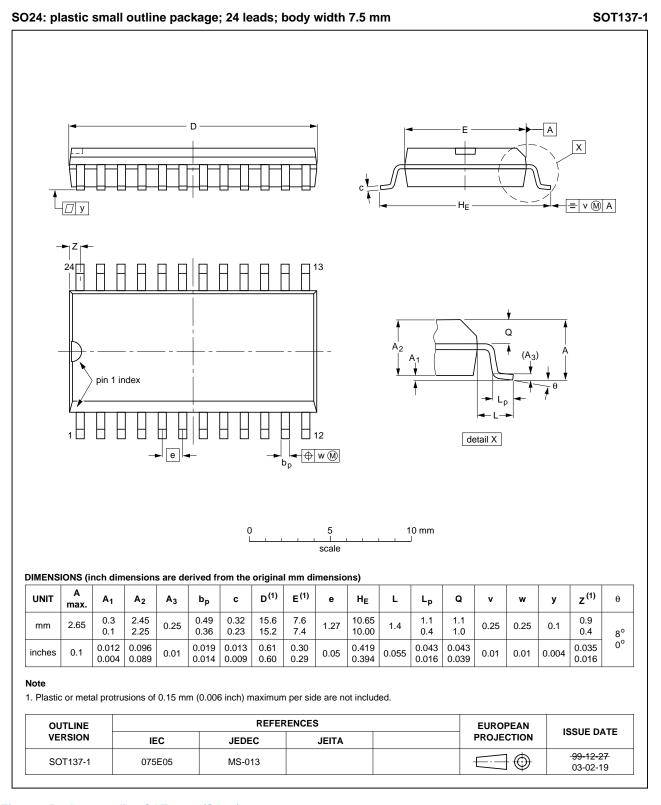


Fig 8. Package outline SOT137-1 (SO24)

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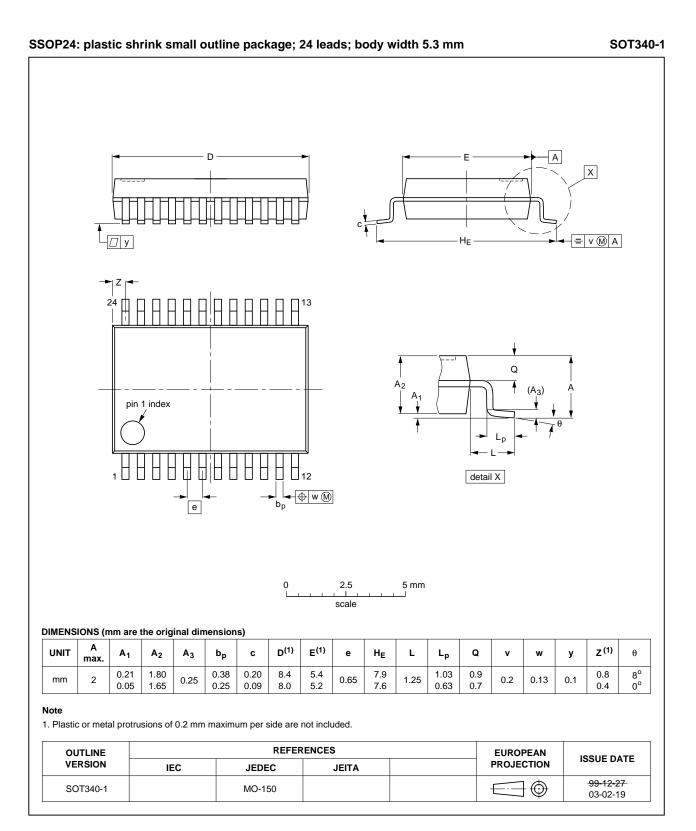


Fig 9. Package outline SOT340-1 (SSOP24)

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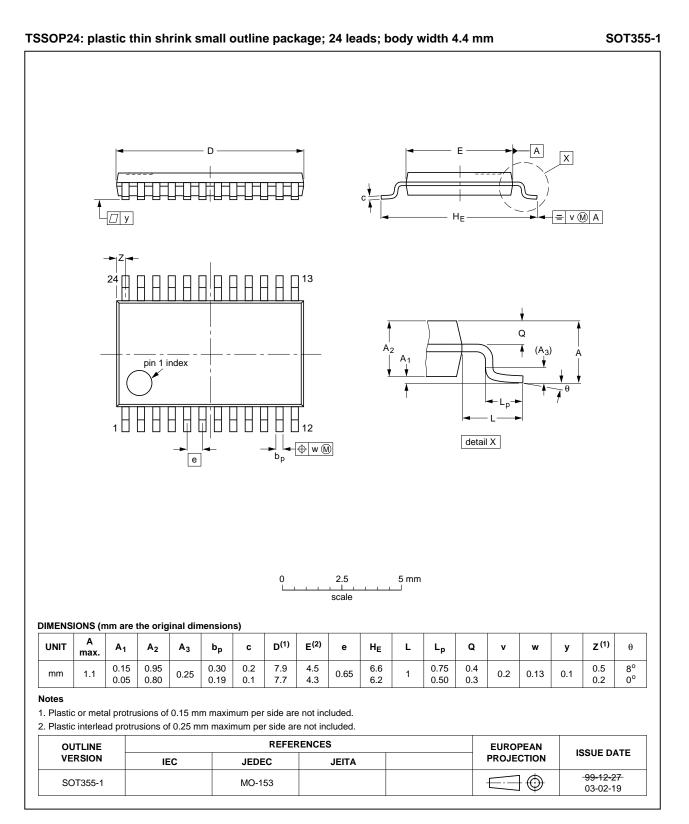


Fig 10. Package outline SOT355-1 (TSSOP24)

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13. Abbreviations

Table 9. Abbreviations				
Acronym	Description			
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
MM	Machine Model			
-				

14. Revision history

Table 10.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT827 v.5	20111107	Product data sheet	-	74ABT827 v.4
Modifications:	 Legal pages 	updated.		
74ABT827 v.4	20100401	Product data sheet	-	74ABT827 v.3
74ABT827 v.3	20100224	Product data sheet	-	74ABT827 v.2
74ABT827 v.2	19980116	Product specification	-	74ABT827 v.1
74ABT827 v.1	19950906	Product specification	-	-

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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